

Notice of References Cited	Application/Control No. 10/589,227		Applicant(s)/Patent Under Reexamination KEMP ET AL.	
	Examiner Janet L. Epps-Smith		Art Unit 1633	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-7,196,054	03-2007	Drohan et al.	514/2
*	C	US-2002/0018757	02-2002	Harichian et al.	424/59
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	K	US-			
	L	US-			
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NON-PATENT DOCUMENTS

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	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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